

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/830,030 ICHIKAWA ET AL.	
		Examiner Hien Tran	Art Unit 1764	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,274,099	08-2001	Maus et al.	422/180
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O	WO 96/12876	05-1996	WO	Maus et al	--
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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